

**Search Notes**

Application/Control No.

10/776,962

Examiner

Than Nguyen

Applicant(s)/Patent under  
Reexamination

MIZUSHIMA ET AL.

Art Unit

2187

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Update WEST Inventor IEEE	3/20/2007	NTV